Classification

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This material is based on Chapters 2 and 4 of Introduction to Statistical Learning (ISL) and parts of Chapter 4 of Elements of Statistical Learning (ESL). We will tend to follow ISL more closely, and look to ESL for occasional additional higher level material. There may be some slight changes to the notation.

For the past several lectures, we have been focused on the supervised learning problem where we observe inputs X and a quantitative output y and assuming

$$Y = f(X) + \epsilon$$

where f is a fixed but unknown function of $X = X_1, \dots, X_p$ and ϵ is a mean zero random error term which is independent of X.

In practice, we often encounter a qualitative or categorical output y, with elements that each take on one of M distinct values. Sometimes these distinct values are also called classes, and the problem of predicting a future output value or class is referred to as classification.

If we want to predict future values of the output, it no longer makes sense to think about minimizing

$$E[(Y - \hat{f}(X))^2]$$

when Y is qualitative. Rather, our goal will be to obtain predictions \hat{Y} based on estimated functions of the inputs $\hat{f}(X)$ that correctly identify the value the observed outpout is most likely to take on, i.e. we want to obtain predictions \hat{Y} from $\hat{f}(X)$ that satisfy $\hat{Y} = Y$ as often as possible. We refer to this as predictions that minimize the **error rate** and we refer to the estimated function $\hat{f}(X)$ mapping from $\hat{f}(X)$ to \hat{Y} as a classifier.

Let $I(y_i \neq \hat{y}_i)$ refer to an indicator function that is equal to 0 if $y_i = \hat{y}_i$, i.e. if the prediction for the *i*-th training data point matches the observed value of the output, and 1 otherwise. We can quantify the performance of a classifier on the training data via the **training error rate**,

$$\sum_{i=1}^{n} I(y_i \neq \hat{y}_i).$$

Analogously to the setting where the output is quantitative, we can also quantify the performance of a classifier on test data that were not used to fit the classifier. Letting (x_0, y_0) refer to an arbitrary data point that has not been seen before, we define the **test error rate** as

$$I(y_0 \neq \hat{y}_0). \tag{1}$$

Again, we can imagine averaging this over all possible observations that we haven't seen before but may in the future. The best classifier will minimize the average test error rate over test data that were not used to fit the classifier.

So far the definitions of the error rate, training error rate, and test error rate are a bit awkward, because they do not explicitly depend on the $\hat{f}(X)$, rather they depend on $\hat{f}(X)$ implicitly through \hat{Y} . Relatedly, thinking of the output as the sum of an unknown function of the inputs and a mean zero error is no longer meaningful - what is E[Y|X] = f(X) if Y is qualitative? It doesn't make sense!

Accordingly, we will make the relationship between $\hat{f}(X)$ and \hat{Y} more explicit. It can be proven that (1) is minimized on average by a classifier that predicts the class that is most likely given the inputs, i.e. if $v_j = 1, \ldots, v_M$ represents all of the possible values that Y can take on and if the probability that Y takes on value v_j given inputs X is known $\Pr(Y = v_j | X)$, this classifier assigns predictions \hat{y}_0 according to

$$\hat{y}_0 = \operatorname{argmax}_i \Pr(Y = v_j | x_0),$$

Note that when M = 2, this corresponds to predicting whichever class has probability $Pr(Y = v_j | x_0) > 0.5$. This suggests defining

$$f_j(X) = \Pr(Y = v_j | X).$$

We now have a subscript j associated with f(X) that reflects the fact that we need to define these probabilities for every possible value of Y.

Note that because $j=1,\ldots,M$ indexes all of the possible values that the output Y could take on, $\sum_{j=1}^{M}\Pr(Y=v_j)=\sum_{j=1}^{M}f_j(X)=1$. This means that given M-1 probabilities, we can always reconstruct the remaining probability. For this reason, we will sometimes models for qualitative output only specify $\Pr(Y=v_j)=f_j(X)$ and estimate $f_j(X)$ for M-1 values of j, most frequently for $j=2,\ldots,M$ or $j=1,\ldots,M-1$.

Just as in the regression setting where we could decompose the performance of an estimated classifier into reducible and irreducable, we can do something similar in the classification setting. The equivalent to irreducible error in the classification setting is the **Bayes error rate**,

$$1 - E[\max_{i} f_i(X)], \tag{2}$$

where the expectation is taken with respect to X. This describes the error rate even if the true probablities $f_j(X)$ were known. The Bayes error rate is equal to 0 when the **Bayes decision boundary**, which describes the set of values of X for which all possible values of the outcome are equally likely perfectly separates the outputs. This corresponds to the setting where $\max_j Pr(Y=v_j|X)=1$ for all X and the outputs are deterministic functions of the inputs. In real life (and furthermore in this *statistical* learning class in which we are studying random outputs), the outputs are rarely deterministic functions of the inputs and the Bayes error rate is rarely 0.

Now we will introduce our first classifier which is very closely related to based on K-nearest neighbors regression, K-nearest neighbors classification. Like its regression counterpart, KNN classification is one of the simplest non-parametric methods for classification.

Let $\mathcal{N}_i^{(K)}$ refer to the set of K indices of observed values of the predictor that are closest to x_i . Then the KNN estimate of $f_i(x_i)$ is

$$\hat{f}_j(x_i) = \frac{1}{K} \sum_{k \in \mathcal{N}_i^{(K)}} I(y_k = v_j)$$

and the KNN classifier assigns the prediction $\hat{y}_i = v_j$ where v_j is the value of the output associated with the highest estimated probability $\hat{f}_i(x_i)$

Again, the value of K is chosen by the user and determines the bias and variance of the estimate of f. Smaller K correspond to less biased but more variable estimates, whereas larger K correspond to (potentially) more biased and less variable estimates.

Just as in the regression setting, the performance of KNN classifiers depends on how K is chosen and if K is chosen to be too small, KNN classifiers can overfit the data. Furthermore, the performance of KNN classifiers also deteriorates rapidly as p, the number of predictors and/or dimension of X, increases. This is because it is harder to find neighbors in high dimensions. This is related to the idea of the **curse of dimensionality**.

This leads us to parametric classifiers. In what follows we will mainly consider the **binary** setting When Y is **binary** with M = 2 levels, we will refer to the levels of Y as equal to $v_1 = 0$ or $v_2 = 1$, specify

 $Pr(Y = 1) = f_2(X)$, and drop the subscript on $f_2(X)$, letting $f(X) = f_2(X)$. We can recover $f_1(X)$ from f(X) according to $f_1(X) = 1 - f(X)$. Note that the KNN classifier's estimate of f(X) in this case is identical to the estimate of f(X) obtained from KNN regression.

Similarly, the simplest parametric classifier is obtained by using linear regression to estimate f(X). We assume $f(X) = \beta_0 + \beta_1 X_1 + \dots + \beta_p X_p$ and estimate $\beta_0, \beta_1, \dots, \beta_p$ by finding the values $\hat{\beta}_0, \hat{\beta}_1, \dots, \hat{\beta}_p$ that minimize the least squares criterion

$$\sum_{i=1}^{n} (y_i - b_0 - x_{i1}b_1 - \dots - x_{ip}b_p)^2,$$

with respect to b_0, b_1, \ldots, b_p . Then predictions \hat{Y} can be obtained by setting $\hat{Y} = I(\hat{\beta}_0 + \hat{\beta}_1 X_1 + \cdots + \hat{\beta}_p X_p > 0.5)$. As in the regression case, there is only a unique minimizer of the least squares criterion when p < n, i.e. we have more observations than predictors, and when the predictors x_1, \ldots, x_p aren't too correlated with each other. We emphasize that this is only reasonable in the binary setting with M = 2 when the output is defined to take on values 0 and 1.